Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/531,454	DERIE ET AL.
Examiner	Art Unit
John Kreck	3673

SEARCHED				
Class	Subclass	Date	Examiner	
		<u></u>		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST lext seach attached	3/13/2006	JΚ
text updated	317107	0-
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